# STA2002: Probability and Statistics II Hypothesis Testing I

Fangda Song and Ka Wai Tseng

School of Data Science, CUHK(SZ)

September, 2025

### Introduction

#### In this lecture we will introduce

- Important concepts in hypothesis testing
  - Null hypothesis  $H_0$  and alternative hypothesis  $H_1$
  - Test statistic T and critical region C
  - Type I and Type II error
  - ullet Significance level lpha
  - p-value
- Hypothesis testing for mean
- Suggested reading: Chapter 8.1 of the textbook.

# Motivating example

#### **Example**

Let X equal the breaking strength of a steel bar. If the bar is manufactured by process I,  $X \sim N(50,36)$ . It is hoped that if process II (a new process) is used,  $X \sim N(55,36)$ . Given a large number of steel bars manufactured by process II, how could we test whether the five-unit increase in the mean breaking strength was realized?

- Based on the observed the breaking strength of steel bars under process II
- Make a judgment: five-unit increase or not

# Formulate $H_0$ and $H_1$

Suppose we have  $X_1, X_2, \cdots, X_n \overset{\text{i.i.d.}}{\sim} N(\mu, 36)$ 

- Null hypothesis  $H_0$ : An initial belief/claim/assumption on the values that  $\mu$  can take
- Alternative hypothesis  $H_1$ : The competing belief/claim/assumption against which we would like to test the initial belief/claim/assumption
- Simple hypothesis: a hypothesis in which  $\mu$  only takes on one value.
- Composite hypothesis: a hypothesis in which  $\mu$  takes on a range of values.

#### **Example**

Simple null hypothesis  $H_0$ :  $\mu=50$ 

Composite null hypothesis  $H_0: \mu \leq 50$ 

Simple alternative hypothesis  $H_1$ :  $\mu=55$ 

Composite alternative hypothesis  $H_1: \mu > 55$ 

# Formulate $H_0$ and $H_1$

#### Different types of hypothesis

- $H_0$ :  $\mu = 50$ ,  $H_1$ :  $\mu = 55$ .
- (One-sided hypothesis test)  $H_0$ :  $\mu = 55$ ,  $H_1$ :  $\mu > 55$ .
- (One-sided hypothesis test)  $H_0$ :  $\mu = 55$ ,  $H_1$ :  $\mu < 55$ .
- (Two-sided hypothesis test)  $H_0: \mu = 55, H_1: \mu \neq 55.$
- $H_0: \mu \leq 55, H_1: \mu > 55.$

# Critical Region C and Test Statistic T

ullet Denote the space of the sample by  $\mathcal{D}$ , that is,

$$\mathcal{D} := \{(x_1, x_2, \dots, x_n) | x_i \in S_X, i = 1, 2, \dots, n\}.$$

- A test of  $H_0$  versus  $H_1$  is based on a subset C of D. This set C that we reject  $H_0$  is called the **critical region**
- ullet The region is usually specified in terms of **test statistic** T.

#### **Example**

In the previous example, we have

Test statistics  $T = \bar{X} \sim N(\mu, 36/n)$ 

Critical region  $C = \{(x_1, x_2, \cdots, x_n) \in \mathcal{D} | \bar{x} \geq 53\}$ 

#### **Decision Rule**

- Once we formulate  $H_0$  and  $H_1$ , we collect data, say  $x_1, \ldots, x_n$ , to see whether  $H_0$  is favoured or  $H_1$  is favoured.
- Then we can come up with a corresponding decision rule, based on the data  $x_1, \ldots, x_n$ :
  - Reject  $H_0$  (Accept  $H_1$ ), if  $(x_1, \ldots, x_n) \in C$ ,
  - Retain  $H_0$  (Reject  $H_1$ ), if  $(x_1, \ldots, x_n) \notin C$ .

#### **Example**

If  $\bar{x} \geq 53$ , we reject  $H_0$ . Otherwise, if  $\bar{x} < 53$ , we fail to reject  $H_0$ .

### Recall the example

#### **Example**

Let X equal the breaking strength of a steel bar. If the bar is manufactured by process I,  $X \sim N(50,36)$ . It is hoped that if process II (a new process) is used,  $X \sim N(55,36)$ . Given a large number of steel bars manufactured by process II, how could we test whether the five-unit increase in the mean breaking strength was realized?

Suppose we have  $X_1, X_2, \cdots, X_n \stackrel{\text{i.i.d.}}{\sim} N(\mu, 36)$ 

- Simple null hypothesis  $H_0: \mu = 50$
- Simple alternative hypothesis  $H_1$ :  $\mu = 55$
- Critical region  $C = \{x \ge 53\}$
- Test statistics  $\bar{X} \sim N(\mu, 36/n)$
- Decision rule: if  $\bar{x} \geq 53$ , we reject  $H_0$ . Otherwise, if  $\bar{x} < 53$ , we fail to reject  $H_0$ .

We may draw incorrect conclusion and commit errors in hypothesis testing. It can happen in two ways:

	$H_0$ true	$H_1$ true
Reject H <sub>0</sub>	Type I error	Correct
Fail to Reject H <sub>0</sub>	Correct	Type II Error

- Type I error: Reject  $H_0$  when  $H_0$  is true.
- Type II error: Fail to reject  $H_0$  when  $H_0$  is false.

The probability of a type I error

$$\alpha = \Pr(\text{Test makes Type I Error}) = \Pr(T \in C; H_0).$$

The probability of a type II error

$$\beta = \Pr(\text{Test makes Type II Error}) = \Pr(T \notin C; H_1).$$

#### **Example**

 $X_1,\ldots,X_n \overset{i.i.d.}{\sim} \mathcal{N}(\mu,36)$  with n=16. We take the critical region  $\mathcal{C}=\{\bar{x}\geq 53\}$ . What is the probability of a type I error and a type II error in the following test

$$H_0$$
:  $\mu = 50$  against  $H_1$ :  $\mu = 55$ ?

**Solution:** We know test statistic  $T = \bar{X} \sim N(\mu, 36/n)$ . Under  $H_0$ ,

$$\bar{X} \sim N(50, 36/16),$$

and under  $H_1$ ,

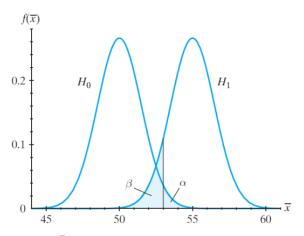
$$\bar{X} \sim N(55, 36/16)$$
.

As a result,

$$\alpha = \Pr(\bar{X} \ge 53; H_0) = \Pr\left(Z \ge \frac{53 - 50}{\sqrt{36/16}}\right) = 0.0228.$$

$$\beta = \Pr(\bar{X} < 53; H_1) = \Pr\left(Z < \frac{53 - 55}{\sqrt{36/16}}\right) = 0.0913.$$

**Note:** by changing the critical region C,  $\alpha$  increases (decreases) while  $\beta$  decreases (increases), so both errors cannot be reduced at the same time.



PDF of  $\bar{X}$  under  $H_0: \mu = 50$  and  $H_1: \mu = 55$ .

# Significance Level

- Most of the time we fix the probability of type I error  $\alpha$ , for example, we take  $\alpha=0.05=5\%$ , and determine the corresponding critical region.
- The value of  $\alpha$  is called the **significance level** of the test.
- We can also be more conservative, and for example, take  $\alpha = 0.01$ .

#### **Example**

Let

$$\Pr(\bar{X} \ge c; H_0) = \Pr\left(Z \ge \frac{c - 50}{\sqrt{36/16}}\right) = 0.05,$$

we have 
$$\frac{c-50}{\sqrt{36/16}} = z_{0.05} \Rightarrow c = 52.48$$

### *p*-value: Observed Significance Level

- p-value is the probability of observing a more extreme test statistic (in the direction that favours  $H_1$ ), given that  $H_0$  is true.
- A small p-value indicates the data is unlikely coming from  $H_0$ , and so the data is perhaps better explained by  $H_1$ .
- We reject  $H_0$  if the p-value  $\leq \alpha$ , where  $\alpha$  is the significance level.
- p-value is also called the observed significance level.

#### **Example**

Given the observed test statistics  $\bar{x} = 56$ , "more extreme" means:

- $\bar{X} \ge 56$ , for  $H_0: \mu = 50$  versus  $H_1: \mu = 55$ ;
- $\bar{X} \ge 56$ , for  $H_0: \mu = 55$  versus  $H_1: \mu > 55$ ,
- $\bar{X} \leq$  56, for  $H_0: \mu =$  55 versus  $H_1: \mu <$  55,
- ullet  $ar{X} \geq$  56 or  $ar{X} \leq$  54, for  $H_0: \mu =$  55 versus  $H_1: \mu \neq$  55,

# **Hypothesis Testing for Normal Mean**

Suppose that  $X_1, \ldots, X_n \overset{i.i.d.}{\sim} N(\mu, \sigma^2)$ . We would like to conduct hypothesis testing on  $\mu$ , and the discussion is separated into the following two cases:

- Case 1:  $\sigma^2$  is known
- Case 2:  $\sigma^2$  is unknown

# Three Approaches to Hypothesis Testing

- P-value approach:
  - ullet Compute p-value and compare it to significance level lpha
  - Reject  $H_0$  if p-value  $\leq \alpha$
- Critical region approach
  - Define rejection region under  $H_0$  and calculate test statistic
  - Reject  $H_0$  if statistic falls in critical region
- Confidence interval approach
  - ullet Construct (1-lpha) confidence interval and check if null value is included in CI
  - Reject H<sub>0</sub> if null value is not included in CI

These three approaches are equivalent!

We consider the test statistic

$$T:=\frac{\bar{X}-\mu_0}{\sigma/\sqrt{n}}.$$

- Under  $H_0: \mu = \mu_0, \ T \sim N(0,1).$
- Once we observe the data  $x_1, \ldots, x_n$ , we can compute

$$z=\frac{\bar{x}-\mu_0}{\sigma/\sqrt{n}}.$$

For the one-sided test  $H_0$ :  $\mu = \mu_0$ ,  $H_1$ :  $\mu > \mu_0$ 

p-value is

$$p = \Pr(T > z; H_0) = \Pr(Z > z),$$

$$p ext{-value} = \Pr(Z > z) \le \alpha \quad (p ext{-value approach})$$
  
 $\Leftrightarrow z \ge z_{\alpha} \quad \text{(critical region approach)}$   
 $\Leftrightarrow \mu_0 \notin \left(\bar{x} - z_{\alpha} \frac{\sigma}{\sqrt{n}}, \infty\right) \quad \text{(confidence interval approach)}$ 

For the one-sided test  $H_0$ :  $\mu = \mu_0$ ,  $H_1$ :  $\mu < \mu_0$ 

p-value is

$$p = \Pr(T < z; H_0) = \Pr(Z < z),$$

$$p\text{-value} = \Pr(Z < z) \le \alpha$$

$$\Leftrightarrow z \le -z_{\alpha}$$

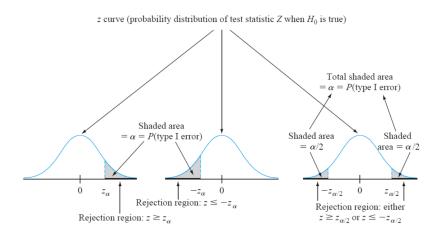
$$\Leftrightarrow \mu_0 \notin \left(-\infty, \bar{x} + z_{\alpha} \frac{\sigma}{\sqrt{n}}\right)$$

For two-sided test  $H_0$ :  $\mu = \mu_0$ ,  $H_1$ :  $\mu \neq \mu_0$ 

p-value is

$$p = \Pr(|T| > |z|; H_0)$$
  
=  $\Pr(Z > |z|) + \Pr(Z < -|z|)$   
=  $2\Pr(Z > |z|).$ 

$$\begin{aligned} & p\text{-value} = 2 \Pr(Z > |z|) \le \alpha \\ \Leftrightarrow & |z| \ge z_{\alpha/2} \\ \Leftrightarrow & \mu_0 \notin \left( \bar{x} - z_{\alpha/2} \frac{\sigma}{\sqrt{n}}, \bar{x} + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right) \end{aligned}$$



- Essentially, we replace the standard normal distribution by t-distribution with df= (n-1) and  $\sigma^2$  by  $S^2$  in Case 1.
- We consider the test statistic

$$T:=\frac{\bar{X}-\mu_0}{S/\sqrt{n}}.$$

- Under  $H_0$ :  $\mu = \mu_0$ ,  $T \sim t(n-1)$ , t distribution with n-1 degrees of freedom.
- Once we observe the data  $x_1, \ldots, x_n$ , we can compute

$$t=\frac{\bar{x}-\mu_0}{s/\sqrt{n}}.$$

For the one-sided test  $H_0: \mu = \mu_0$ ,  $H_1: \mu > \mu_0$ ,

p-value is

$$p = \Pr(T > t; H_0) = \Pr(T > t; T \sim t(n-1)).$$

$$p ext{-value} = \Pr(T > t; T \sim t(n-1)) \le \alpha$$
  
 $\Leftrightarrow t \ge t_{\alpha}(n-1)$   
 $\Leftrightarrow \mu_0 \notin \left(\bar{x} - t_{\alpha}(n-1)\frac{s}{\sqrt{n}}, \infty\right)$ 

For the one-sided test  $H_0$ :  $\mu = \mu_0$ ,  $H_1$ :  $\mu < \mu_0$ ,

p-value is

$$p = \Pr(T < t; H_0) = \Pr(T < t; T \sim t(n-1)).$$

$$p$$
-value =  $\Pr(T < t; T \sim t(n-1)) \le \alpha$   
 $\Leftrightarrow t \le -t_{\alpha}(n-1)$   
 $\Leftrightarrow \mu_0 \notin \left(-\infty, \bar{x} + t_{\alpha}(n-1) \frac{s}{\sqrt{n}}\right)$ 

For the one-sided test  $H_0$ :  $\mu = \mu_0$ ,  $H_1$ :  $\mu \neq \mu_0$ ,

p-value is

$$\begin{split} p &= \Pr(|T| > |t|; H_0) \\ &= \Pr(T > |t|; T \sim t(n-1)) + \Pr(T < -|t|; T \sim t(n-1)) \\ &= 2\Pr(T > |t|; T \sim t(n-1)). \end{split}$$

$$\begin{aligned} & p\text{-value} = 2 \Pr(T > |t|; T \sim t(n-1)) \le \alpha \\ \Leftrightarrow & |t| \ge t_{\alpha/2}(n-1) \\ \Leftrightarrow & \mu_0 \notin \left(\bar{x} - t_{\alpha/2}(n-1) \frac{s}{\sqrt{n}}, \bar{x} + t_{\alpha/2}(n-1) \frac{s}{\sqrt{n}}\right) \end{aligned}$$

# **Example of two-sided test**

#### **Example**

Let X (in millimeters) equal the growth in 15 days of a tumor induced in a mouse. Assume that the distribution of X is  $N(\mu,\sigma^2)$ . We shall test the null hypothesis  $H_0: \mu=4.0$  against the two-sided alternative hypothesis  $H_1: \mu \neq 4.0$ . We observe n=9 observations with  $\bar{x}=4.3, s=1.2$  and set a significance level of  $\alpha=0.10$ .

We have

$$t = \frac{4.3 - 4}{1.2/\sqrt{9}} = 0.75$$

and  $t_{0.05}(8) = 1.86$ 

### **Example of two-sided test**

• p-value approach:

$$p = 2 \Pr(T > 0.75; T \sim t(8)) = 0.4747 > 0.1,$$

so we fail to reject  $H_0$  at 10% significance level.

Critical region approach:

$$|t| = 0.75 < 1.86,$$

so we fail to reject  $H_0$  at 10% significance level.

Confidence interval approach: The 90% two-sided Cl is

$$4.3 \pm 1.86 \frac{1.2}{\sqrt{9}} = [3.556, 5.044],$$

which includes 4, so we fail to reject  $H_0$  at 10% significance level.

### **Example of one-sided test**

#### **Example**

Suppose that we have n=25,  $\bar{x}=308.8$ , s=115.15. We would like to test  $H_0: \mu=500$  against  $H_1: \mu<500$ . We take the significance level  $\alpha=0.01=1\%$ .

Then we have

$$t = \frac{308.8 - 500}{115.15/\sqrt{25}} = -8.30$$

and  $t_{0.01}(24) = 2.492$ 

### **Example of one-sided test**

• *p*-value approach:

$$p = \Pr(T < -8.30; T \sim t(24)) = 8.17 \times 10^{-9} < 0.01,$$

so we reject  $H_0$  at 1% significance level.

Critical region approach:

$$t = -8.30 < -2.492$$

so we reject  $H_0$  at 1% significance level.

Confidence interval approach: The 99% one-sided Cl is

$$(-\infty, 308.8 + 2.492 \times 115.15/\sqrt{25}] = (-\infty, 366.191],$$

which does not include 500, so we reject  $H_0$  at 1% significance level.

# **Summary**

Tab	le	1:	Tests	of	hypothe	ses for	one	mean
-----	----	----	-------	----	---------	---------	-----	------

$H_0$	$H_1$	p-value	Critical Region			
$\sigma^2$ known, $Z \sim N(0,1), z = \frac{\tilde{x} - \mu_0}{\sigma/\sqrt{n}}$						
$\mu = \mu_0$	$\mu > \mu_0$	Pr(Z > z)	$z \geq z_{\alpha}$			
$\mu = \mu_0$	$\mu < \mu_0$	Pr(Z < z)	$z \leq -z_{\alpha}$			
$\mu = \mu_0$	$\mu \neq \mu_0$	$2\Pr(Z> z )$	$ z  \ge z_{\alpha/2}$			
$\sigma^2$ unknown, $T \sim t(n-1), t = \frac{x-\mu_0}{s/\sqrt{n}}$						
$\mu = \mu_0$	$\mu > \mu_0$	Pr(T > t)	$t \geq t_{\alpha}(n-1)$			
$\mu = \mu_0$	$\mu < \mu_0$	$\Pr(T < t)$	$t \leq -t_{\alpha}(n-1)$			
$\mu = \mu_0$	$\mu \neq \mu_0$	$2\Pr(T> t )$	$ t  \geq t_{\alpha/2}(n-1)$			

- p-value approach: Reject  $H_0$  if p-value  $\leq \alpha$
- Critical region approach: Reject H<sub>0</sub> if z or t belongs to the critical region
- Confidence interval approach: Reject  $H_0$  if CI excludes  $\mu_0$